Issue	Classification

Application/Control No.	Applicant(s)/Patent under Reexamination						
10/708,804	LEE ET AL.						
Examiner	Art Unit						
Gail Verbitsky	2859						

	IS	SSUE CLASSIFICATION								
ORIGINAL		CROSS REFERENCE(S)								
CLASS SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)								
374 170	33/									
INTERNATIONAL CLASSIFICATION	374	763 117								
601K7 132										
60161126										
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		りんしんがとけ Total Claims Allowed:								
(Assistant Examiner) (Date										
		GAIL VERBITSKY 7 2 2 0.G 0.G 0.G Print Claim(s) Print								
(Legal instruments Examined) (7/05	(Primary Examiner) (Oake)	.							
(Legal instruments Examiner) (yale)									

Claims re	renumbered in the same order as presented by applican			cant	□СРА			☐ T.D.			☐ R.1.47				
Final	Final	Final	Original		Final	Original		Final	Original	·	Final	Original		Final	Original
1 1	31	1	61			91			121	1		151			181
2 2	32	1.	62			92			122			152			182
3 3	33		63	1		93			123			153			183
4 4	34		64	1 [94			124			154			184
5	35		65			95			125			155			185
6 6	36		66			96		`	126			156			186
7 7	37		67	1		97	•		127			157			187
8	38	1 [68	1		98			128	•		158			188
2 9	39		69			99			129	•		159			189
9 10	40		70			100			130			160			190
10 11	41		71			101			131			161			191
12	42		72	1	•	102			132			162			192
13	43	1	73	1		103			133			163			193
14	44		74			104			134			164			194
15	45	1	75	1		105			135			165			195
16	46	1	76	1		106			136			166			196
17	47		77	1		107			137			167			197
18	48	-	78	1		108			138			168		·	198
19	49	-	79	1 .	•	109			139			169			199
20	. 50		80			110			140			170			200
21	51		81	1		111			141			171			201
22	52		82	1		112			142			172			202
23	53	— 	83	1		113			143			173			203
24	54		84	1	· •• • • • • • • • • • • • • • • • • •	114			144			174			204
25	55		85	1 F		115			145			175			205
26	56		86	1		116			146			176			206
27	57	_	87	1		117			147			177			207
28	58	{	88	1		118			148			178	ll	j j	208
29	59	-	89	1	-	119			149			179	•		209
30	60		90	1 F		120	[150			180			210